

<b>Notice of References Cited</b>	Application/Control No. 10/523,070		Applicant(s)/Patent Under Reexamination YAGI ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,247,276	07-2007	Schuppich et al.	422/129
*	B	US-6,736,983	05-2004	Thies et al.	216/2
	C	US-			
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	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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